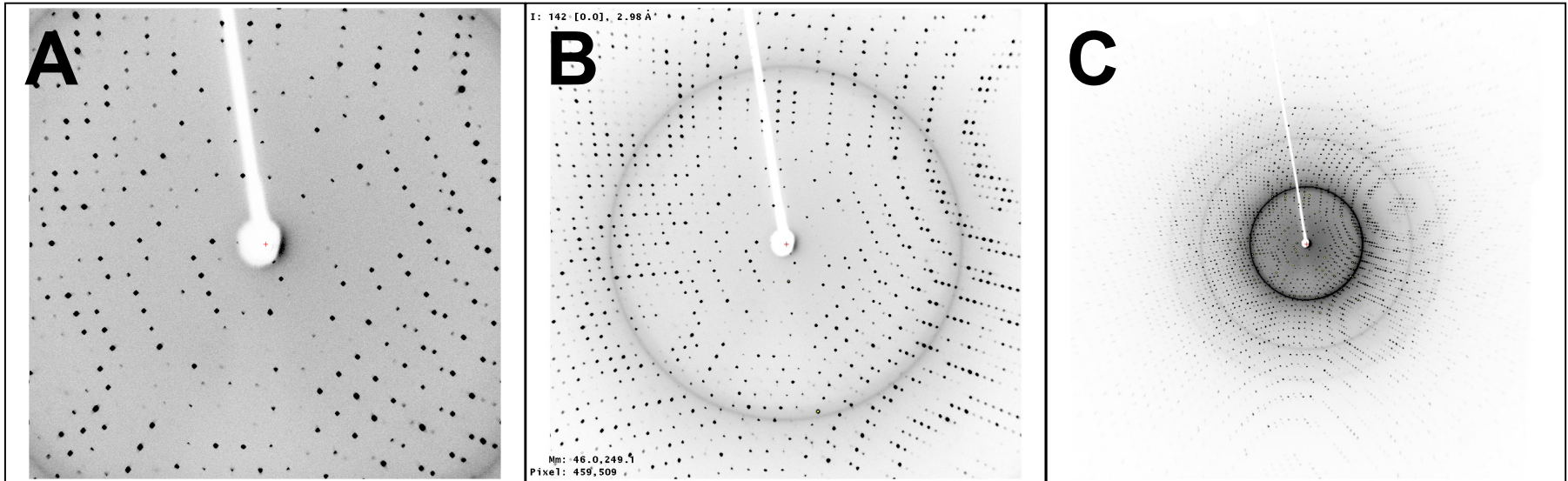
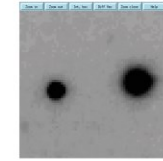
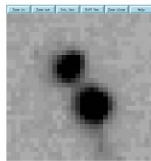
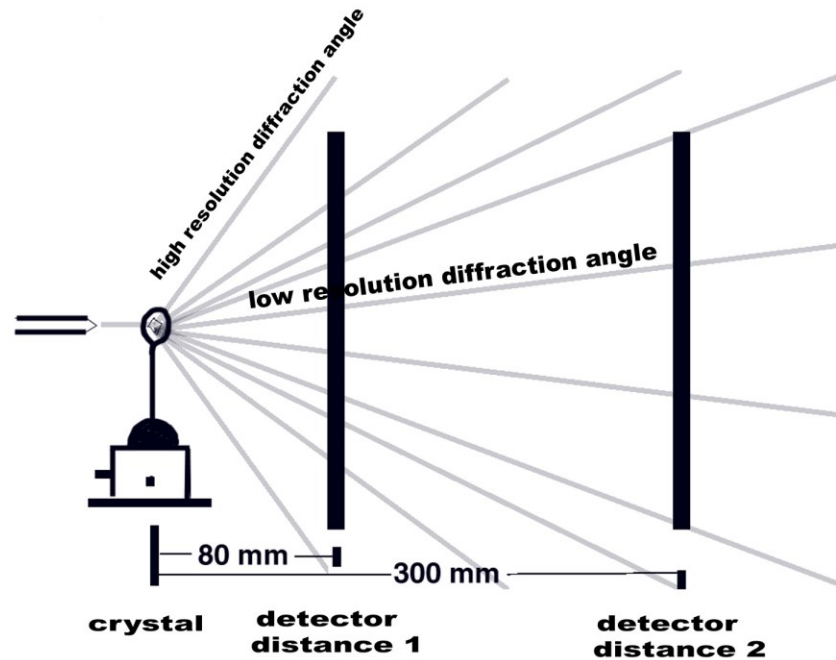


Distance

The 3 diffraction images below were recorded using different crystal-to-detector distances: 80, 250, or 450 mm. Match each image with its corresponding distance: 80, 250, or 450 mm. All patterns were recorded from the same crystal using the same X-ray wavelength.



DISTANCE



short distance

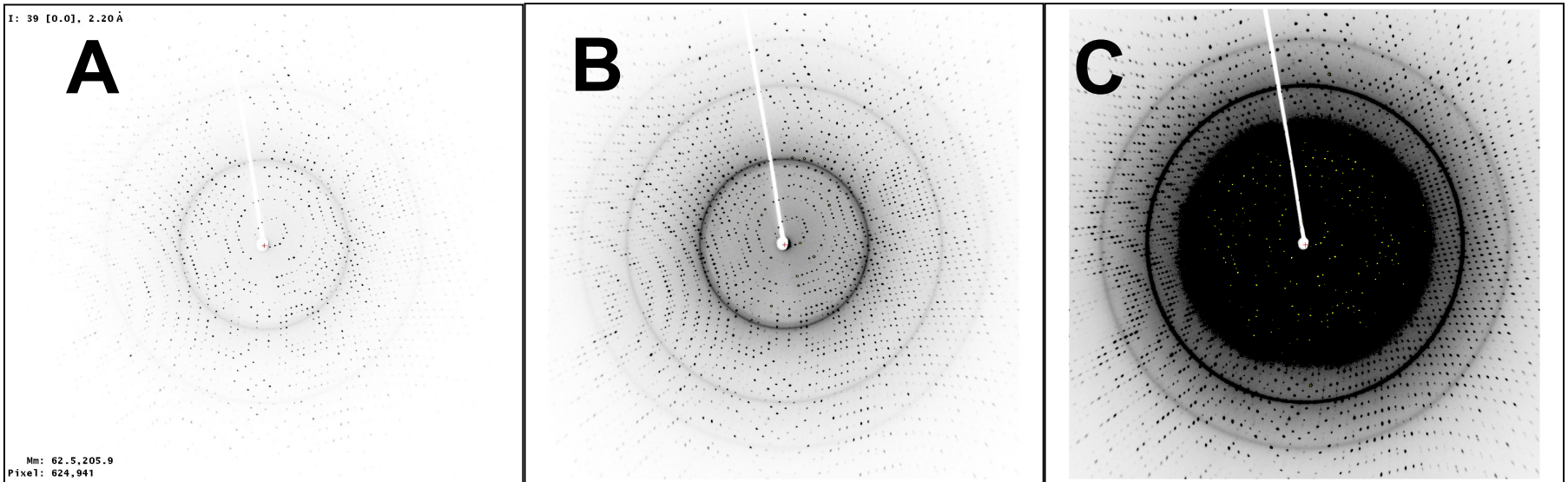
+able to collect high angle (resolution) diffraction
-danger of overlapping spots on detector
(i.e. poor spatial resolution)
practical when the unit cell is small (<100 Ang)
60 mm minimum distance

long distance

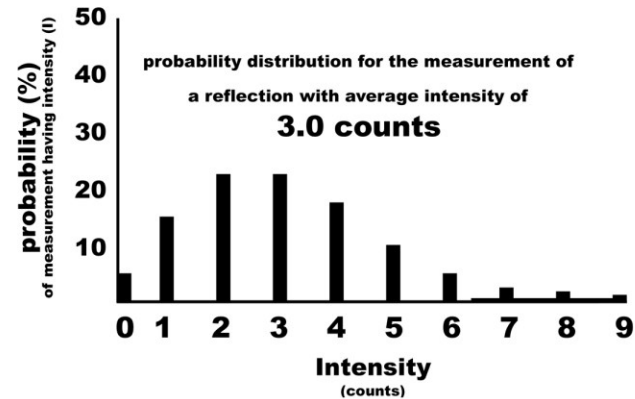
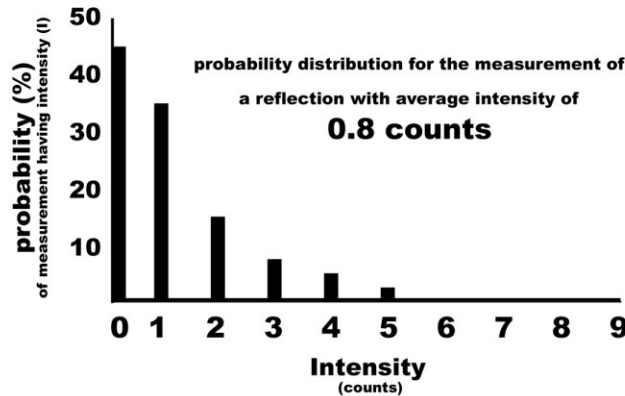
limited to low angle (resolution) diffraction -
no danger of overlapping spots on detector +
(i.e. good spatial resolution)
necessary when unit cell is large (>100 Ang)
350 mm maximum distance

Time

The 3 diffraction images below were recorded using exposure times. Match each image with its corresponding length of exposure: 12 s, 60 s, or 300 s. All patterns were recorded from the same crystal using the same X-ray wavelength.



TIME



for Poisson distribution

$$\sigma_I = \sqrt{I}$$

$$\text{fractional uncertainty} = \frac{\sigma_I}{I} = \frac{\sqrt{I}}{I} = \frac{1}{\sqrt{I}}$$

$$\text{fractional uncertainty} = \frac{1}{\sqrt{0.8}} = 1.118$$

smaller σ , but larger fractional uncertainty

$$\text{fractional uncertainty} = \frac{1}{\sqrt{3}} = 0.577$$

larger σ , but smaller fractional uncertainty

short exposure

long exposure

- + quicker data set
- less accurate measurements
- + no chance of overloading detector pixels

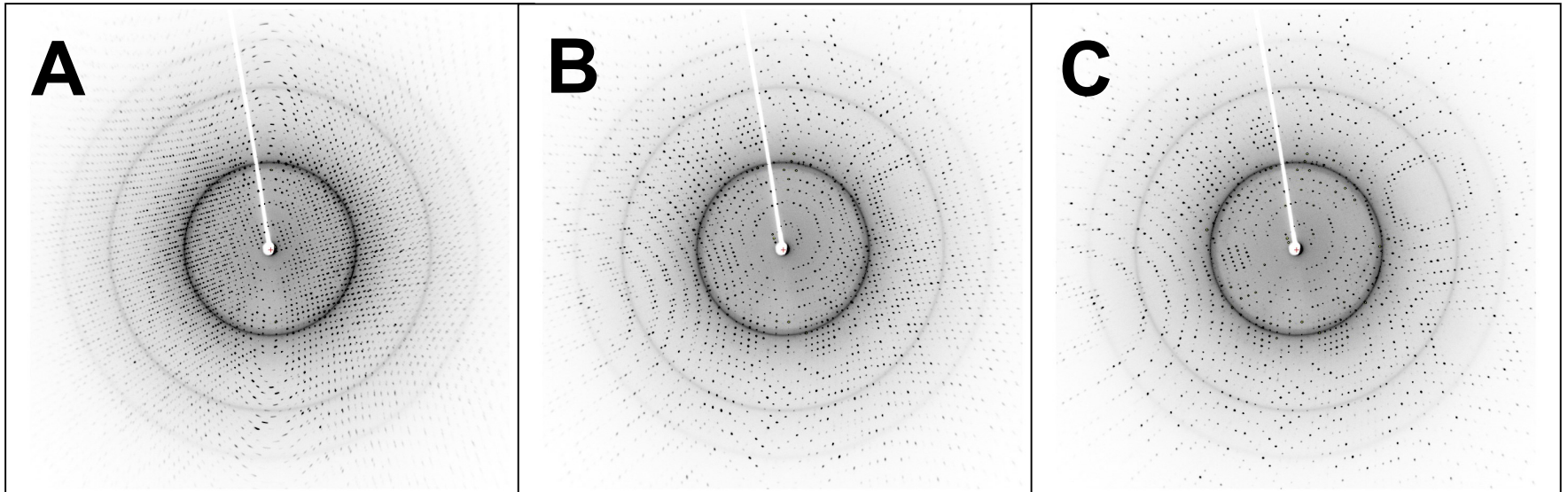
practical for big crystals
or high intensity synchrotron beams.
1 sec/exposure at synchrotron

- time consuming -
- more accurate measurements +
- may overload detector pixels -
- necessary for small crystals
- or weaker home x-ray sources

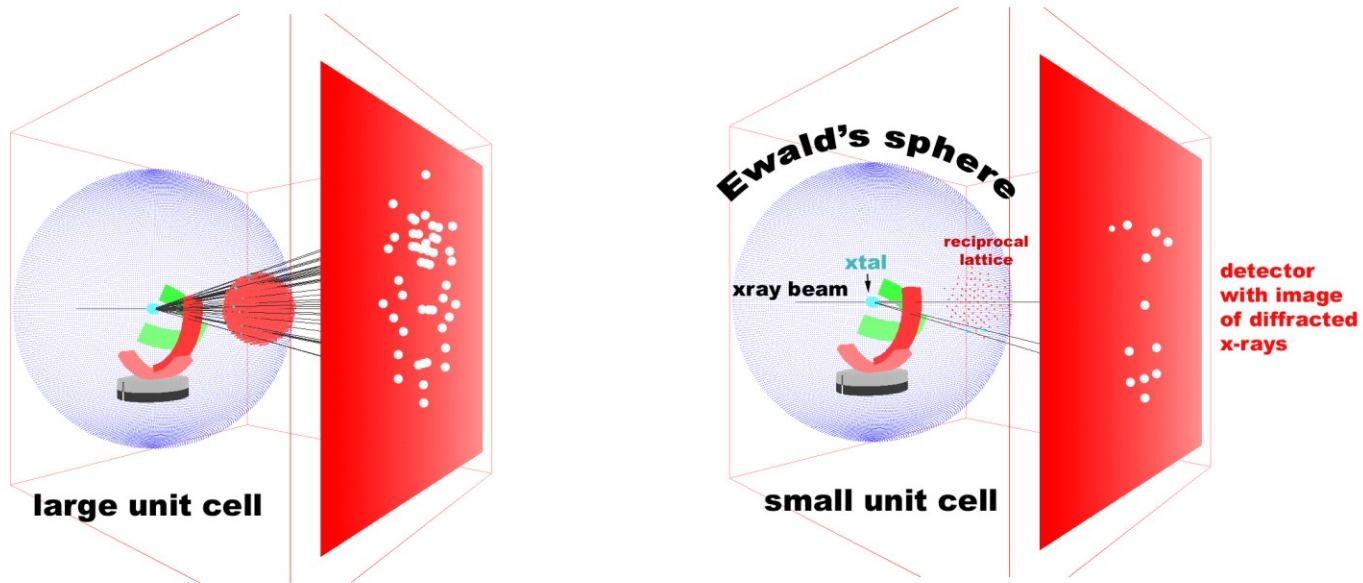
3 min/exposure on CCD home source

Oscillation Angle

The 3 diffraction images below were recorded while rotating the crystal by different amounts. Match each image with its corresponding rotation: 0.10° , 1.00° , or 5.00° . All images were recorded from the same crystal at the same X-ray wavelength.



OSCILLATION ANGLE



**fewer degrees
oscillation**

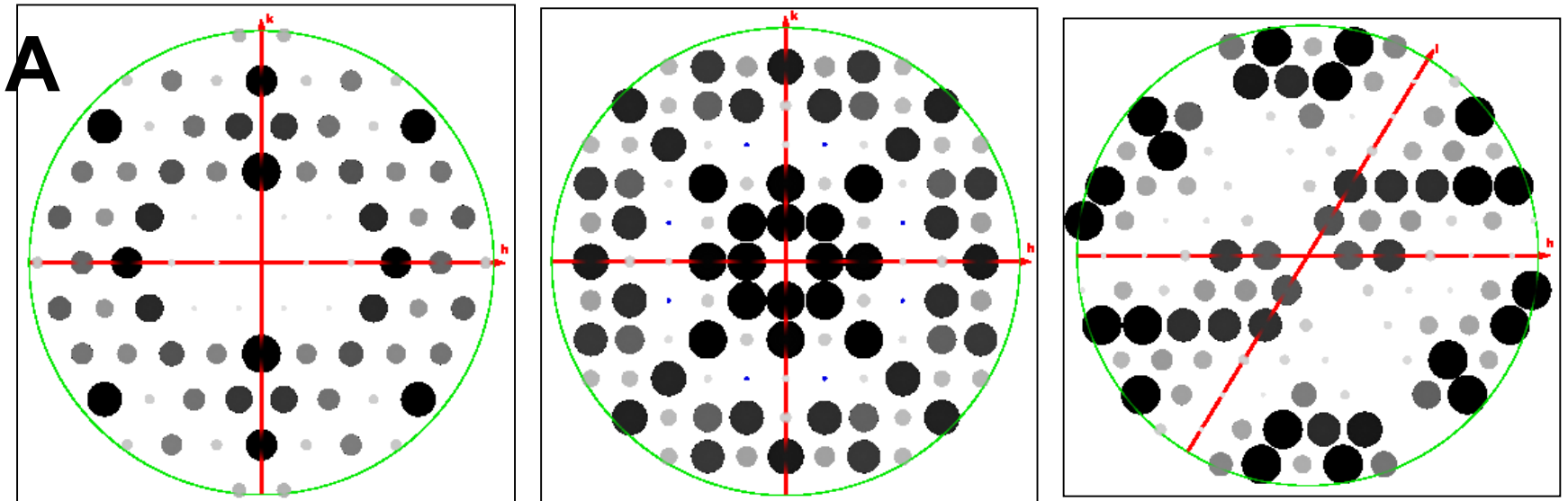
- + less risk of spot overlap
 - requires more exposures, time consuming
 - + more accurate intensity measurements
- 0.5-1.0 degree for typical proteins**

**more degrees
oscillation**

- more risk of spot overlap -
 - requires fewer exposures, quicker collection +
 - less accurate measurements -
- 2.0 degrees for typical DNA oligos**

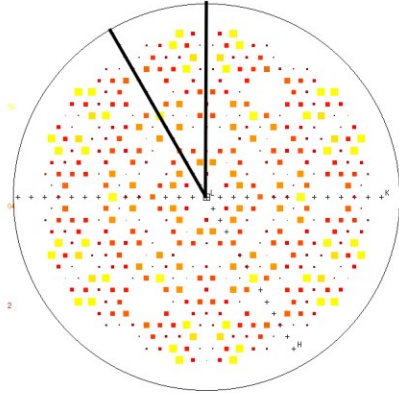
Total Rotation Range

The 3 reciprocal lattices below reveal different degrees of rotational symmetry. Indicate the minimum amount of crystal rotation required to capture the unique part of each diffraction pattern: 45° , 90° , or 180° .



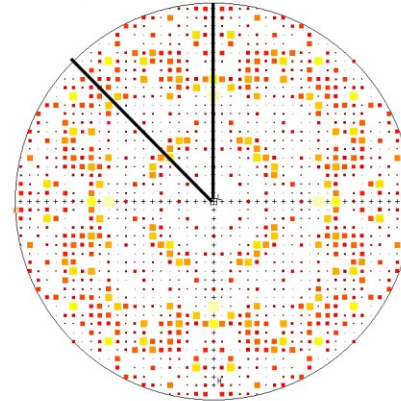
total number of **DEGREES** of rotation

30 degrees unique



**P622 space group
(higher symmetry)**

45 degrees unique



**P422 space group
(lower symmetry)**

**fewer degrees
of rotation**

- risk lower completeness
 - poor redundancy
 - + quicker data collection
- practical for high symmetry space groups**

**more degrees
of rotation**

- completeness assured +
 - high redundancy +
 - time consuming to collect data -
- required for low symmetry space groups**